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Quantum Hall Effect in a 2D Semiconductor with Large Spin Orbit Coupling

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Abstract

We perform magnetotransport studies of atomically thin InSe field-effect transistors with large Rashba spin-orbit coupling (SOC), and extract the Landau level (LL) gaps via thermal activation measurements. Surprisingly, the Landau level gaps at even and odd filling factors are extrapolated to have positive and negative intercepts at B=0, respectively, which result from the spin-split Landau spectrum. We also show that for a material with large spin-orbit coupling, its LL gaps may vary non-linearly and non-monotonically as a function of magnetic field. Thus, its effective mass and g-factor cannot be reliably extracted using conventional expressions, but depend rather sensitively on the SOC's strength and tunability.

The burgeoning field of spin-orbitronics[1, 2] takes advantage of the spin-orbit coupling (SOC) phenomenon, in which an electron moving in an electric field of an inversion symmetrybroken lattice experiences an effective magnetic field in its rest frame, giving rise to spin-split bands even in the absence of an external magnetic field. A large SOC has been employed to engineer novel spintronic and topological devices, such as quantum spin Hall effect, quantum anomalous Hall effect and spin orbit torque[1, 3, 4]. In two-dimensional (2D) materials, SOC has been demonstrated to give rise to valley Hall effect[5, 6] and Ising superconductivity in transition metal dichalcogenides[7]. A large SOC is also at the heart of engineering topological superconductivity by coupling a strong spin-orbit coupled material to s-wave superconductors[8].

One aspect that distinguishes SOC in 2D materials is its tunability – it can be modified by gate[9-14], proximity[12-14] and layer number[15], giving rise to ever more increasing possibilities for tailoring material properties and device functionalities. In GaAs-based semiconductor heterostructures, two effective masses arising from the spin-split bands have been measured by far-infrared cyclotron[16] and quantum oscillations[17] studies. However, the effect of SOC on the Landau level (LL) gaps in the quantum Hall (QH) regime with well-separated charge gaps, another prototypical 2D phenomenon, has been scarcely studied to date.

Here, using atomically thin InSe layers with unprecedented mobility and large tunable SOC, we study magnetotransport in the quantum Hall regime. Under a large magnetic field *B*, well-resolved QH plateaus are observed, with well quantized Hall resistance R_{xy} . Using thermal activation measurements of longitudinal resistance (R_{xx}) , we extract the charge gaps Δ of the first 3 LLs. Surprisingly, for filling factor v=4 and 6, $\Delta(B)$ displays positive intercepts at B=0, while

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the intercepts are negative for $\nu=3$ and 5. These peculiar behaviors are accounted for by the large SOC that is tuned by an external electric field. Gaps of the lowest LL are anomalously small, suggesting significantly increased effective mass due to electronic interactions. Finally, we show that LL gaps for devices with large SOC may not scale linearly or monotonically with *B*, thus care must be taken when extracting band parameters from QH gaps.

Atomically thin InSe is a recent addition to the family of 2D materials, with high mobility[18, 19] and a thickness-dependent band gap that ranges from 1 to 3 eV[20-22]. Bulk InSe crystals are grown by the Bridgeman method, and are confirmed by transmission electron microscopy (TEM) to be γ -phase with rhombohedral stacking[15]. Few-layer InSe flakes are exfoliated from bulk crystals onto PDMS stamps. These flakes are picked up by and sandwiched between hexagonal BN (hBN) sheets. Few-layer graphene is used to achieve ohmic contacts to the semiconductor. The entire stacks are dropped onto Si/SiO₂ substrates, where the degenerately doped Si serves as the back gate. A schematic of the device is illustrated in Fig. 1a.

Fig. 1b presents the differential longitudinal resistance dR_{xx}/dB of a typical 4-layer InSe device as a function of magnetic field *B* and gate voltage V_g . Prominent Shubnikov-de Haas (SdH) oscillations emerge at $B\sim3T$, and quantized Hall resistance plateaus at $B\sim9T$, indicating unprecedented mobility (Fig. 1b-c). An unusual feature of the SdH oscillations is the emergence of beating patterns. As an example, a line trace $\Delta R(B)$ at V_g =-4.5V is shown on Fig. 1d, where the oscillations amplitude reaches a node (minimum) at $B\sim7T$ and increases thereafter. This behavior is part of a beating pattern, arising from the interference of oscillations of two different frequencies, and is indicative of the presence of two distinct Fermi surfaces. As we have demonstrated previously, in InSe, these Fermi surfaces originate from the spin-split bands due to Rashba SOC[15], with dispersion $E = \frac{\hbar k^2}{2m^*m_e} \pm |\alpha k|$ (Fig. 1c inset). Here m^* is the reduced effective mass of charge carriers, m_e is the rest mass of electrons, e electron charge, h the Planck constant, k the wave vector, and α is the Rashba parameter.

We now focus on the quantum Hall states in high magnetic fields, where we are able to resolve QH states for filling factors v=3 through 6, with well-quantized Hall plateaus (Fig. 2a-b). Here we present data from a 6-layer device D1. To gain insight into the QH states in InSe, we measure $R_{xx}(V_g)$ at different magnetic fields and temperatures *T*. As temperature increases, valleys in R_{xx} become shallower, but persist up to T > 60K at B=25T, which are attributed to a combination of the high device quality and the low electronic effective mass (Fig. 2c). Fig. 2d-e plots R_{xx} vs 1/T in Arrhenius plot at several different *B* for filling factors 4 and 5, respectively. We extract the LL gaps by fitting each resistance valley to $R_{xx} = R_0 + Ae^{-\Delta v/2k_BT}$, where Δ_v is the LL gap of the QH state at filling factor v, R_0 is the residual resistance and k_B the Boltzmann constant (Fig. 2d,f). The extracted gap values for v=3 through 6 are shown as a function of *B* in Fig. 2e. For conventional semiconductors with two-fold spin degeneracy, the LL gaps are

$$\Delta_{odd} = g\mu_B B - 2\Gamma_v$$

$$\Delta_{even} = \hbar\omega_c - g_0 \mu_B B - 2\Gamma_v \tag{1}$$

where g is the effective Landé factor that can be enhanced from its bare electron value $g_0=2$ through exchange interactions, μ_B is Bohr magneton, $\omega_c = eB/m^*m_0$ the cyclotron frequency, e

electron charge, and $\Gamma_{\nu}>0$ the LL broadening. For even filling factors, since the highest filled LL is unpolarized, the Landé *g*-factor is assumed to adopt the bare value of $g_0=2$.

Fitting the data points to Eq. (1), the slopes of $\Delta(B)$ yield an extracted effective mass that varies from 0.25 at v=6 to 0.35 at v=4 and a g-factor ~4 that are considerably enhanced from their bare values. The variation in m^* at different filling factors could in principle be attributed to anharmonicity of the bands, though the values found are larger than those found in bulk or in few-layer InSe[18, 19]. More surprisingly, the fitted lines for $\Delta_{v=4}$ and $\Delta_{v=6}$ extrapolate to a finite *positive* intercept at B=0, while that for odd filling factors to a negative intercept. Conventionally, a positive intercept is usually taken as an indication of a quantum anomalous Hall state whose gap persists to B=0[23]; however, the absence of topologically non-trivial bands or any discernible features in R_{xy} at B=0 rules out such a scenario.

These anomalous behaviors of the LL gaps prompt us to examine the spin-split bands induced by a large Rashba SOC. The Landau level (LL) spectrum is then given by[4, 24, 25]

$$E_0 = \frac{1}{2}\hbar\omega_c - \frac{g\mu_B}{2}B$$
$$E_N^{\pm} = \hbar\omega_c \left[N \pm \frac{1}{2}\sqrt{(1-gm^*/2)^2 + N\frac{\Delta_R^2}{E_F\hbar\omega_c}}\right], N \ge 1$$
(2)

Here N is the LL index, $\Delta_R = 2|\alpha k_F|$ is the Rashba spin splitting, α the Rashba parameter, k_F is the Fermi momentum, E_F the Fermi energy. In the large B limit, Eq. (2) can be expanded to yield

$$E_N^{\pm} = \hbar\omega_c \left(N \pm \frac{1}{2}\right) \mp \frac{g\mu_B}{2} \pm 2N\alpha^2\eta, N \ge 1$$

where $\eta = \frac{m^* m_0}{\hbar^2} \frac{1}{1 - gm^*/2}$, thus leading to energy gaps at even and odd filling factors,

$$\Delta_{odd} = g\mu_B B - 2\nu\alpha^2\eta\tag{3}$$

$$\Delta_{even} = \hbar\omega_c - g\mu_B B + 2\nu\alpha^2\eta$$

Comparing with Eq. (1), the same g-factor is used for all filling factors in Eq. (3), and the SOC introduces an additional term $\pm 2\nu\alpha^2\eta$, which can give rise to finite intercepts at B=0. Another effect, which is often underappreciated, is the variation of α with magnetic field at constant filling factor. This arises from α 's dependence on the inversion-breaking out-of-plane electric field E_{\perp} , $\alpha = \alpha_0 + \alpha' E_{\perp}$, where α_0 is the intrinsic Rashba parameter of InSe, and α' parametrizes the effectiveness of the electric field at tuning the SOC coupling. α' can be positive or negative, depending on its orientation relative to the built-in inversion asymmetry of the lattice. Thus, the magnitude of spin splitting depends not only on charge density but also on E_{\perp} . Consequently, for a back-gated device, at a given filling factor, *n* scales with *B*, giving rise to proportionally increasing E_{\perp} and thus α . Since the exact values of electric field drop across the InSe flake depends on screening that is density- and layer-dependent, and requires self-consistent Hartree calculation, here we define $E_{\perp} = \frac{C_{Tg}V_{Tg} - C_{Bg}V_{Bg}}{2\varepsilon_0}$, i.e. electric field as experimentally imposed by the top and back gates without considering effect of screening (here C_{tg} and C_{bg} are capacitance per unit area between the gates and InSe, and ε_0 is the permittivity of vacuum). In the QH regime, $E_{\perp} = \frac{ve^2}{(2\varepsilon_0h)}B \cong (2.2vB)$ mV/nm.

Summarizing, the presence of Rashba SOC therefore introduces significant modification to LL gaps: in the large *B* limit, and collecting the dependencies on *B* and E_{\perp} , Eq. (2) can be expanded to yield energy gaps

$$\Delta_{even} = \left[\frac{\hbar e}{m^* m_e} - g\mu_B + 8.8 \times 10^{-3} \nu^2 \alpha_0 \alpha' \eta\right] B + \left[2\nu \alpha_0^2 \eta - 2\Gamma_\nu\right]$$
(4a)

$$\Delta_{odd} = [g\mu_B - 8.8 \times 10^{-3} \nu^2 \alpha_0 \alpha' \eta] B - [2\nu \alpha_0^2 \eta + 2\Gamma_{\nu}]$$
(4b)

Eq. (4) differs from the more conventional Eq. (1) in two important aspects. First, for small LL broadening, the LL gaps at even and odd filling factors have positive and negative intercepts at B=0. respectively, in good agreement with our data. Second, the "hidden" dependence of α on B in single-gated devices gives rise to an additional linear-B term, which has been ignored in prior measurements of LL gaps in 2D semiconductors with large SOC.

We fit the experimental data of Δ at $\nu=3$ and 5 to Eq. (4b), and extract g-factors of 3.7 and 3.8, respectively, which are significantly enhanced from the bare value of 2. Using these g values, as well as $\alpha_0 = 0.3 \times 10^{-11}$ eV m, and $\alpha'=1.1 \times 10^{-2}$ e nm² from previous measurements[15], we then fit the data of Δ at $\nu=2$ and 4, and obtain $m^* \sim 0.23$ at $\nu=4$ and $m^*=0.21$ at $\nu=6$. The extracted values of m^* and g obtained by using Eq. (1) and (4) are summarized in Table 1.

To explore the QH state in the lowest LL, we turn to a dual-gated device; by applying V_{bg} =75V and tuning the top gate voltages V_{tg} , we are able resolve the QH states v=1 and 2. Fig. 3a displays $R_{xy}(V_{tg}, B)$ at V_{bg} =75V; as shown by the line trace $R_{xy}(V_{tg})$ at B=45T (Fig. 3b), well quantized Hall plateaus with resistance h/ve^2 are observed. We note that this is the first time that the v=1 state is observed experimentally in bulk or atomically thin InSe, again attesting to the quality of the devices. Using thermal activation measurements (Fig. 3c), the LL gaps are estimated to be $\Delta_{v=2}/B \sim 2.5$ K/T and $\Delta_{v=1}/B \sim 1.0$ K/T, respectively (Fig. 3d). If we were to use the more conventional expression Eq. (1), this would yield $m^*=0.35$ and g=1.5. However, we seek to provide a more accurate account of m^* and g of the lowest LL by taking Rashba SOC-modified band structures into account.

To this end, taking advantage of the dual-gated geometry of the device, we extract both the intrinsic Rashba SOC strength and its tunability by mapping R_{xx} as a function of v and E_{\perp} at B=10T (Fig. 4a). At constant v, maxima in R_{xx} transitions into minima as E_{\perp} varies, and vice versa; such transition indicate crossings of LLs as α is modulated by E_{\perp} . We can satisfactorily account for the modulation by taking $\alpha = (3.5 + 3.0 E_{\perp}) \times 10^{-11}$ eV m[15]. This value of α is sufficiently large that the large-*B* expansion used in Eq. (4) is no longer valid, even at B=45T. We therefore numerically calculate the LL gaps at $V_{bg}=75$ V using Eq. (2) and $\alpha = 3.5 + 3.0 E_{\perp}$, and found that the data are best fit by $m^*=0.43$ and g=1.3 for v=1 and 2. This anomalously large m^* likely arises from strong electronic interactions in the lowest LL at large *B*. The small *g*-factor is surprising, since it tends to increase with decreasing charge density in GaAs-based 2DEGs[26]. We currently do not have explanation for this observation, but note that it may be related to the band's inharmonicity, detailed scattering mechanisms or electronic interactions in the presence of strong magnetic fields (~40-45T).

At the first glance, the values of g and m^* obtained by fitting to Eq. (1) and Eq. (2) are not significantly different (see Table 1). This superficial similarity, however, appears to be coincidental. Generally, materials with large SOC may exhibit LLs that appear to be non-linear or non-monotonic with B, due to the SOC-induced LL crossings; this effect is particularly relevant (yet oft-ignored) for devices where only a single gate is used to control the charge density, since

 E_{\perp} is inevitably modified in conjunction. A full investigation of of LLs in these materials requires two gates to control *n* and E_{\perp} independently. To illustrate this point, we plot the LL spectra in Fig. 4c, which are calculated using Eq. (2), $m^*=0.43$, g=1.3, and a constant $\alpha=3.5\times10^{-11}$ eV m. The LL energies of the minority and majority carriers, represented by the red solid lines and blue dotted lines, respectively, cross at numerous points. At each crossing, the LL gap vanishes; before (after) the crossing, it decreases (increases) with increasing *B*, thereby giving rise to a non-monotonic scaling with *B*. Moreover, since the LL spectra depend on α , the gate-induced modulation of E_{\perp} (and therefore α) further modifies the LL gaps. This is captured by the map $\Delta(v, B)$ (Fig. 4d), in which the complex dependence of the LL gap on v and *B* is illustrated as the color contrast. Evidently, for materials with a large SOC, non-linear and non-monotonic dependence on *B* is the rule rather than exception. Therefore, care must be exercised when extracting band parameters from QH gaps in large spin-orbit coupled materials; fitting data to Eq. (1), particularly over a limited range or using sparse data points in *B*, will likely lead to erroneous results.

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Device	v	$\Delta_{V}(\mathrm{K/T})$	Using Eq. (1)		Using Eq. (4)	
			g	<i>m</i> *	g	m^*
V_{bg} =75V	1	1.0±0.1	1.5		1.3	
$(\alpha = 3.5 \times 10^{-11} \text{ eV})$	2	2.5±0.2	2	0.35	1.3	0.40
m, $\alpha'=3.1 \text{ e nm}^2$)						
No top gate	3	2.54	3.8		3.7	
$(\alpha = 0.3 \times 10^{-11} \text{ eV})$	4	3.24±0.3	2	0.29	3.7	0.22
m, $\alpha' = 1.1 \text{ e nm}^2$)	5	2.5±0.4	3.7		3.8	
	6	4.1±0.6	2	0.25	3.8	0.20

Table 1. Summary of measured LL gaps and extracted g and m^* values.

Fig. 1. Schematic and typical transport characteristics of a typical few-layer InSe device. (a). Schematic and optical image of a device. (b). Differentiated longitudinal resistance dR_{xx}/dB vs. V_g and B. (c). Hall resistance $R_{xy}(B)$, showing QH plateaus for $8 \le v \le 14$. Inset: schematics of spin-split Fermi surfaces from Rashba SOC; the arrows denote spin polarization directions. (d). Line trace dR_{xx}/dB at V_{bg} =4.5V.



Fig. 2. Magnetotransport data of a 6-layer device at high field. (a). $R_{xx}(V_{bg},B)$ in k Ω at T=0.3 K. The numbers indicate filling factors. (b). $R_{xy}(V_{bg})$ at different *B*, showing quantized plateaus. (c). $R_{xx}(V_{bg})$ at T=0.5K, 3K, 5K, 10K, 15K, 26K, 36K, and 55K, respectively (bottom to top). (d,f). Arrhenius plot of R_{xx} vs 1/T at different *B* for v=4 and 5, respectively. Traces are offset for clarity. (f). Extracted LL gaps for v=3 to 6. The dotted lines are fits to straight lines.



Fig. 3. Thermal activation measurements of LL gaps at high *B*. (a). $R_{xy}(V_{tg}, B)$ in k Ω of a dualgated device at *T*=0.3K and V_{bg} =75V. (b). $R_{xy}(V_{tg})$ at *B*=45T and *T*=0.3K. (c). $R_{xx}(n)$ at *T*=0.35K, 1.5K, 2.5K, 3.8K, 5.2K, 7.4K, 9.7K, 12.1K, 19K, and 25K (bottom to top). (d). Extracted LL gaps for *v*=1 and 2. The dotted lines are fits to straight lines.



Fig. 4. (a). $dR_{xx}(v, E_{\perp})/dn$ at B=10T for the dual-gated device. (b). Simulation calculated using $\alpha = 3.5 + 3.0 E_{\perp}$, where α is in 10⁻¹¹ eV m and E_{\perp} in V/nm. (c). Calculated LL spectra using Eq. (2) and $\alpha=3x10^{-11}$ eV m, $m^*=0.43$ and g=1.3. (d). Calculated LL gaps Δ in K vs v and B using $m^*=0.43$, g=1.3, $\alpha = (3.5 + 3 E_{\perp} \perp) \times 10^{-11}$ eV m and $V_{bg}=75$ V.

